

<b>Notice of References Cited</b>	Application/Control No. 09/916,689	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
	Examiner Ishwar (I. B.) Patel	Art Unit 2827	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,338,767	01-2002	Nakatani et al.	156/233
	B	US-6,324,067	11-2001	Nishiyama, Tousaku	361/761
	C	US-6,129,955	10-2000	Papathomas et al.	427/517
	D	US-5,776,551	07-1998	Pasch, Nicholas F.	427/534
	E	US-5,335,139	08-1994	Nomura et al.	361/321.4
	F	US-5,943,216	08-1999	Schmidt, Dominik J.	361/761
	G	US-6,153,290	11-2000	Sunahara, Hirofumi	428/210
	H	US-5,698,904	12-1997	Tsuji, Masahiro	257/795
	I	US-5,963,429	10-1999	Chen, Philip H.	361/764
	J	US-5,353,195	10-1994	Fillion et al.	361/760
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.